

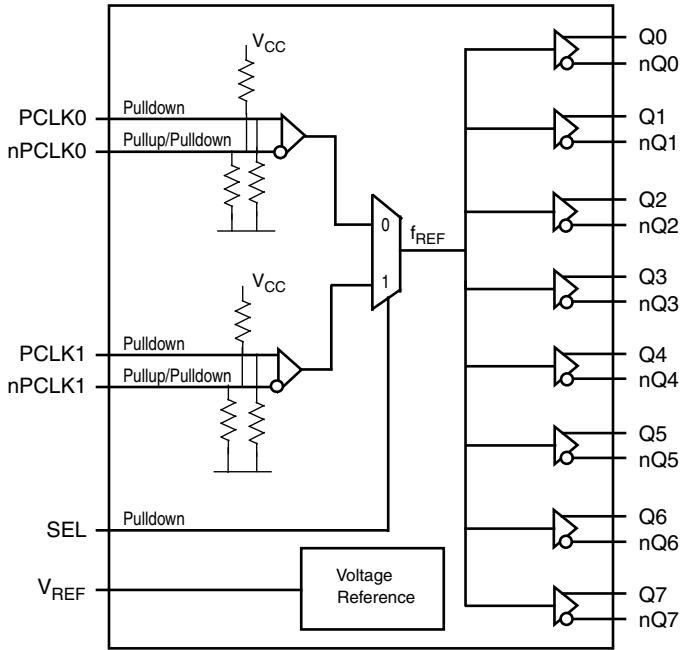
General Description

The 8SLVP1208 is a high-performance differential LVPECL fanout buffer. The device is designed for the fanout of high-frequency, very low additive phase-noise clock and data signals. The 8SLVP1208 is characterized to operate from a 3.3V and 2.5V power supply. Guaranteed output-to-output and part-to-part skew characteristics make the 8SLVP1208 ideal for those clock distribution applications demanding well-defined performance and repeatability. Two selectable differential inputs and eight low skew outputs are available. The integrated bias voltage generators enables easy interfacing of single-ended signals to the device inputs. The device is optimized for low power consumption and low additive phase noise.

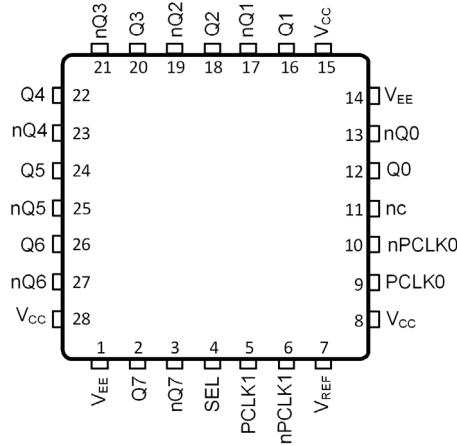
Features

- Eight low skew, low additive jitter LVPECL output pairs
- Two selectable, differential clock input pairs
- Differential pairs can accept the following differential input levels: LVDS, LVPECL, CML
- Maximum input clock frequency: 2GHz
- LVCMS interface levels for the control input (input select)
- Output skew: 28ps (typical)
- Propagation delay: 410ps (maximum)
- Low additive phase jitter, RMS: 54.1fs (maximum) ($f_{REF} = 156.25\text{MHz}$, $V_{PP} = 1\text{V}$, 12kHz - 20MHz)
- Full 3.3V and 2.5V supply voltage
- Maximum device current consumption (I_{EE}): 141mA
- Available in lead-free (RoHS 6), 28-Lead VFQFN package
- 40°C to 85°C ambient operating temperature
- Differential PCLK0, nPCLK0 and PCLK1, nPCLK1 pairs can also accept single-ended LVCMS levels. See Applications section *Wiring the Differential Input to Accept Single-Ended Levels* (Figure 1A and Figure 1B)

Block Diagram



Pin Assignment



8SLVP1208
28-Lead LFCSP
5mm x 5mm x 0.75mm package body
NB Package

Top View

Pin Descriptions and Characteristics

Table 1. Pin Descriptions¹

Number	Name	Type	Description	
1, 14	V _{EE}	Power	Negative supply pins.	
2, 3	Q7, nQ7	Output	Differential output pair. 7 LVPECL interface levels.	
4	SEL	Input	Pulldown	Reference select control. See Table 3 for function. LVCMOS/LVTTL interface levels.
5	PCLK1	Input	Pulldown	Non-inverting differential LVPECL clock/data input.
6	nPCLK1	Input	Pullup/ Pulldown	Inverting differential LVPECL clock/data input. V _{CC} /2 default when left floating.
7	V _{REF}	Output	Bias voltage reference for the nPCLK inputs.	
8, 15, 28	V _{CC}	Power	Power supply pins.	
9	PCLK0	Input	Pulldown	Non-inverting differential LVPECL clock/data input.
10	nPCLK0	Input	Pullup/ Pulldown	Inverting differential LVPECL clock/data input. V _{CC} /2 default when left floating.
11	nc	Unused	Do not connect.	
12, 13	Q0, nQ0	Output	Differential output pair 0. LVPECL interface levels.	
16, 17	Q1, nQ1	Output	Differential output pair 1. LVPECL interface levels.	
18, 19	Q2, nQ2	Output	Differential output pair 2. LVPECL interface levels.	
20, 21	Q3, nQ3	Output	Differential output pair 3. LVPECL interface levels.	
22, 23	Q4, nQ4	Output	Differential output pair 4. LVPECL interface levels.	
24, 25	Q5, nQ5	Output	Differential output pair 5. LVPECL interface levels.	
26, 27	Q6, nQ6	Output	Differential output pair 6. LVPECL interface levels.	

NOTE 1: *Pulldown* and *Pullup* refer to internal input resistors. See [Table 2, Pin Characteristics](#), for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			2		pF
R _{PULLDOWN}	Input Pulldown Resistor			51		kΩ
R _{PULLUP}	Input Pullup Resistor			51		kΩ

Function Table

Table 3. SEL Input Selection Function Table¹

Input	Operation
SEL	
0 (default)	PCLK0, nPCLK0 is the selected differential clock input
1	PCLK1, nPCLK1 is the selected differential clock input

NOTE 1: SEL is an asynchronous control.

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Electrical Characteristics* or *AC Electrical Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V_{CC}	3.63V
Inputs, V_I	-0.5V to $V_{CC} + 0.5V$
Outputs, I_O (LVPECL)	
Continuous Current	50mA
Surge Current	100mA
Input Sink/Source, IREF	$\pm 2mA$
Maximum Junction Temperature, $T_{J,MAX}$	125°C
Storage Temperature, T_{STG}	-65°C to 150°C
ESD - Human Body Model ¹	2000V
ESD - Charged Device Model ¹	1500V

NOTE 1: According to JEDEC/JESD 22-A114/22-C101.

DC Electrical Characteristics

Table 4A. Power Supply DC Characteristics, $V_{CC} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^\circ C$ to $85^\circ C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Power Supply Voltage		3.135	3.3V	3.465	V
I_{EE}	Power Supply Current			110	141	mA
I_{CC}	Power Supply Current	Q0 to Q7 terminated 50Ω to $V_{CC} - 2V$		285	343	mA

Table 4B. Power Supply DC Characteristics, $V_{CC} = 2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^\circ C$ to $85^\circ C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Power Supply Voltage		2.375	2.5V	2.625	V
I_{EE}	Power Supply Current			102	127	mA
I_{CC}	Power Supply Current	Q0 to Q7 terminated 50Ω to $V_{CC} - 2V$		285	341	mA

Table 4C. LVC MOS/LVTTL DC Characteristics, $V_{CC} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^\circ C$ to $85^\circ C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage		$V_{CC} = 3.465V$	2.2		$V_{CC} + 0.3$	V
			$V_{CC} = 2.625V$	1.7		$V_{CC} + 0.3$	V
V_{IL}	Input Low Voltage		$V_{CC} = 3.465V$	-0.3		0.8	V
			$V_{CC} = 2.625V$	-0.3		0.7	V
I_{IH}	Input High Current	SEL	$V_{CC} = V_{IN} = 3.465V$ or $2.625V$			150	μA
I_{IL}	Input Low Current	SEL	$V_{CC} = 3.465V$ or $2.625V$, $V_{IN} = 0V$	-10			μA

Table 4D. LVPECL DC Characteristics, $V_{CC} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^\circ C$ to $85^\circ C$ ¹

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
I_{IH}	Input High Current	PCLK0, nPCLK0 PCLK1, nPCLK1	$V_{CC} = V_{IN} = 3.465V$			150	μA
I_{IL}	Input Low Current		$V_{CC} = 3.465V$, $V_{IN} = 0V$	-10			μA
			$V_{CC} = 3.465V$, $V_{IN} = 0V$	-150			μA
V_{REF}	Reference Voltage for Input Bias		$I_{REF} = 2mA$	$V_{CC} - 1.83$	$V_{CC} - 1.54$	$V_{CC} - 1.25$	V
V_{OH}	Output High Voltage ²			$V_{CC} - 1.23$	$V_{CC} - 1.16$	$V_{CC} - 0.80$	V
V_{OL}	Output Low Voltage ²			$V_{CC} - 1.97$	$V_{CC} - 1.90$	$V_{CC} - 1.70$	V

NOTE 1: Input and output parameters vary 1:1 with V_{CC} .NOTE 2: Outputs terminated with 50Ω to $V_{CC} - 2V$.**Table 4E. LVPECL DC Characteristics, $V_{CC} = 2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^\circ C$ to $85^\circ C$ ¹**

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
I_{IH}	Input High Current	PCLK0, nPCLK0 PCLK1, nPCLK1	$V_{CC} = V_{IN} = 2.625V$			150	μA
I_{IL}	Input Low Current		$V_{CC} = 2.625V$, $V_{IN} = 0V$	-10			μA
			$V_{CC} = 2.625V$, $V_{IN} = 0V$	-150			μA
V_{REF}	Reference Voltage for Input Bias		$I_{REF} = 2mA$	$V_{CC} - 1.64$	$V_{CC} - 1.36$	$V_{CC} - 1.09$	V
V_{OH}	Output High Voltage ²			$V_{CC} - 1.21$	$V_{CC} - 1.00$	$V_{CC} - 0.79$	V
V_{OL}	Output Low Voltage ²			$V_{CC} - 1.92$	$V_{CC} - 1.80$	$V_{CC} - 1.67$	V

NOTE 1: Input and output parameters vary 1:1 with V_{CC} .NOTE 2: Outputs terminated with 50Ω to $V_{CC} - 2V$.

AC Electrical Characteristics

Table 5A. AC Electrical Characteristics, $V_{CC} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^\circ C$ to $85^\circ C^1$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f_{REF}	Input Frequency	PCLK[0:1], nPCLK[0:1]				2	GHz
$\Delta V/\Delta t$	Input Edge Rate	PCLK[0:1], nPCLK[0:1]		1.5			V/ns
t_{PD}	Propagation Delay ²		PCLK[0:1], nPCLK[0:1] to any Qx, nQx for $V_{PP,IN} = 0.1V$ or $0.3V$	160	287	410	ps
$t_{sk(o)}$	Output Skew ^{3, 4}				28	64	ps
$t_{sk(i)}$	Input Skew ⁴				12	65	ps
$t_{sk(p)}$	Pulse Skew		$f_{REF} = 100MHz$		29	70	ps
$t_{sk(pp)}$	Part-to-Part Skew ^{4, 5}				55	140	ps
t_R / t_F	Output Rise/ Fall Time		20% to 80%	29	104	200	ps
$MUX_{ISOLATION}$	Mux Isolation ⁶				76		dB
V_{PP}	Peak-to-Peak Input Voltage ^{7, 8}		$f < 1.5GHz$	0.1		1.5	V
			$f > 1.5GHz$	0.2		1.5	V
V_{CMR}	Common Mode Input Voltage ^{7, 8, 9}			1.0		$V_{CC} - 0.6$	V
V_o (pp)	Output Voltage Swing, Peak-to-Peak		$V_{CC} = 3.3V, f_{REF} \leq 2GHz$	0.5	0.83	1.10	V
			$V_{CC} = 2.5V, f_{REF} \leq 2GHz$	0.5	0.82	1.05	V
V_{DIFF_OUT}	Differential Output Voltage Swing, Peak to Peak		$V_{CC} = 3.3V, f_{REF} \leq 2GHz$	1.0	1.67	2.20	V
			$V_{CC} = 2.5V, f_{REF} \leq 2GHz$	1.0	1.63	2.10	V

NOTE 1: NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 2: Measured from the differential input crossing point to the differential output crossing point.

NOTE 3: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential crosspoints.

NOTE 4: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 5: Defined as skew between outputs on different devices operating at the same supply voltage, same frequency, same temperature and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.

NOTE 6: Qx, nQx outputs measured differentially. See *MUX Isolation* diagram in the *Parameter Measurement Information* section.

NOTE 7: V_{IL} should not be less than -0.3V. V_{IH} should not be higher than V_{CC} .

NOTE 8: For single-ended LVCMOS input applications, please refer to the *Applications Information, Wiring the Differential Input to Accept Single-Ended Levels, Figure 1A* and *Figure 1B*.

NOTE 9: Common mode input voltage is defined as the crosspoint.

Table 5B. AC Electrical Characteristics, Buffer Additive Phase Jitter, T_{JIT} , $T_A = -40^{\circ}\text{C}$ to 85°C ¹

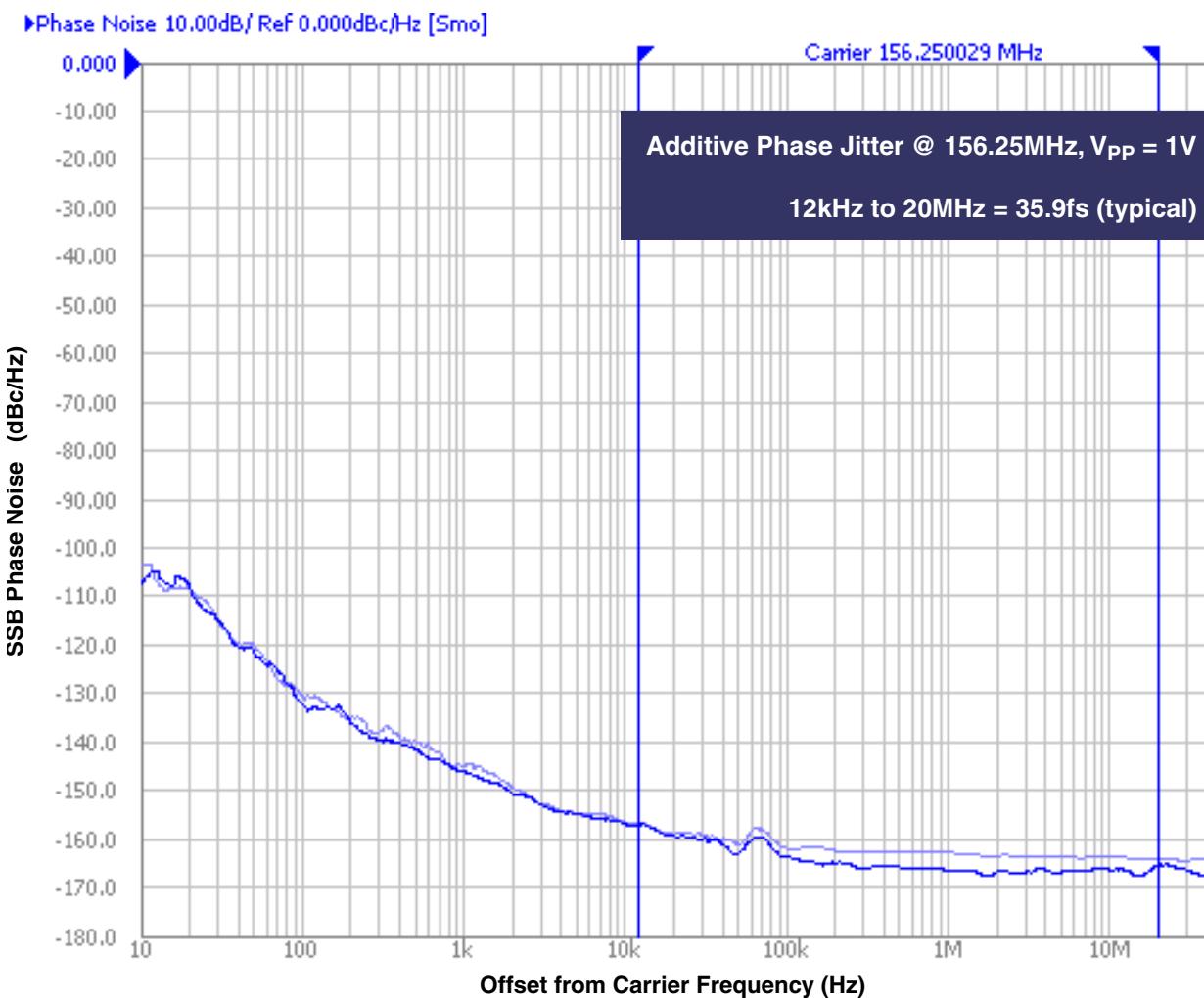
Symbol	Parameter	Test Condition	$V_{CC} = 2.5\text{V} \pm 5\%$, $V_{EE} = 0\text{V}$			$V_{CC} = 3.3\text{V} \pm 5\%$, $V_{EE} = 0\text{V}$			Units
			Min	Typ	Max	Min	Typ	Max	
t_{JIT}	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter Section	$f_{REF} = 122.88\text{MHz}$, Square Wave, $V_{PP} = 1\text{V}$, Integration Range: 1kHz - 40MHz		56.4	87.4		46.8	79.9	fs
		$f_{REF} = 122.88\text{MHz}$, Square Wave, $V_{PP} = 1\text{V}$, Integration Range: 10kHz - 20MHz		42.5	64.5		38.4	60.5	fs
		$f_{REF} = 122.88\text{MHz}$, Square Wave, $V_{PP} = 1\text{V}$, Integration Range: 12kHz - 20MHz		42.5	64.5		38.4	60.5	fs
		$f_{REF} = 156.25\text{MHz}$, Square Wave, $V_{PP} = 1\text{V}$, Integration Range: 1kHz - 40MHz		51.9	69.5		47.4	71.1	fs
		$f_{REF} = 156.25\text{MHz}$, Square Wave, $V_{PP} = 1\text{V}$, Integration Range: 10kHz - 20MHz		41.4	58.6		35.9	54.2	fs
		$f_{REF} = 156.25\text{MHz}$, Square Wave, $V_{PP} = 1\text{V}$, Integration Range: 12kHz - 20MHz		41.4	58.6		35.9	54.1	fs
		$f_{REF} = 156.25\text{MHz}$, Square Wave, $V_{PP} = 0.5\text{V}$, Integration Range: 1kHz - 40MHz		49.8	76.6		44.9	70.2	fs
		$f_{REF} = 156.25\text{MHz}$, Square Wave, $V_{PP} = 0.5\text{V}$, Integration Range: 10kHz - 20MHz		36.9	53.9		31.1	52.3	fs
		$f_{REF} = 156.25\text{MHz}$, Square Wave, $V_{PP} = 0.5\text{V}$, Integration Range: 12kHz - 20MHz		36.8	53.7		31.1	52.3	fs

NOTE 1: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

Additive Phase Jitter

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the **dBc Phase Noise**. This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio

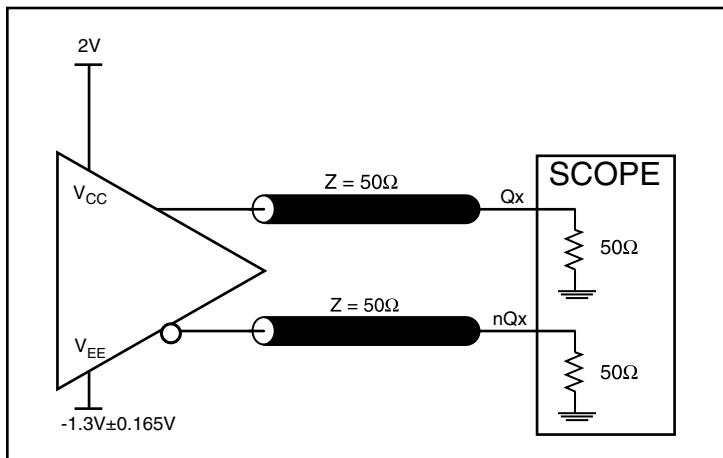
of the power in the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a **dBc** value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.



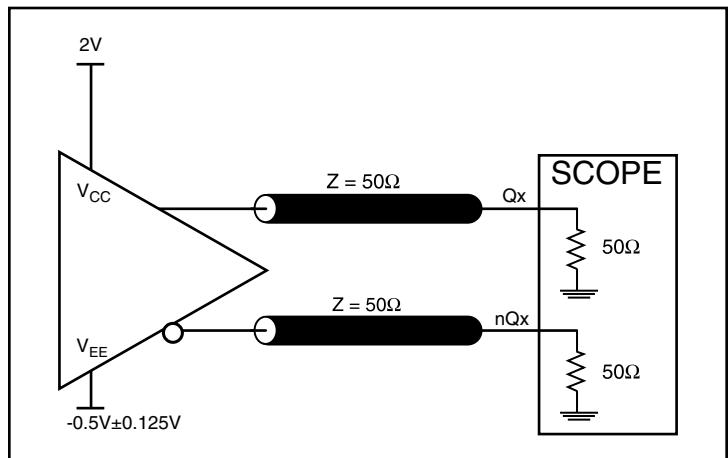
As with most timing specifications, phase noise measurements have issues relating to the limitations of the equipment. Often the noise floor of the equipment is higher than the noise floor of the device. This is illustrated above. The device meets the noise floor of what is shown, but can actually be lower. The phase noise is dependent on the input source and measurement equipment.

Measured using a Wenzel 156.25MHz Oscillator as the input source.

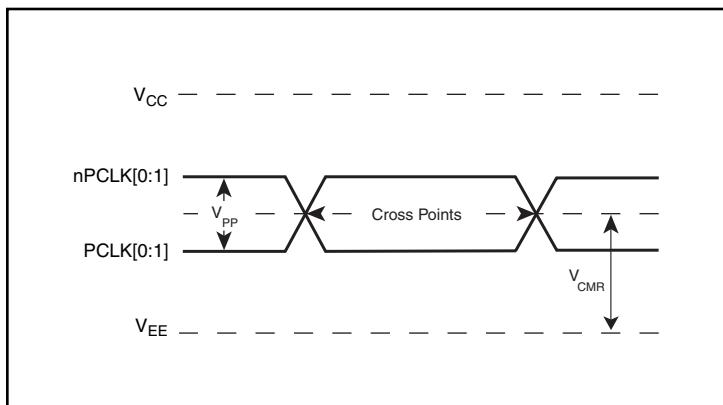
Parameter Measurement Information



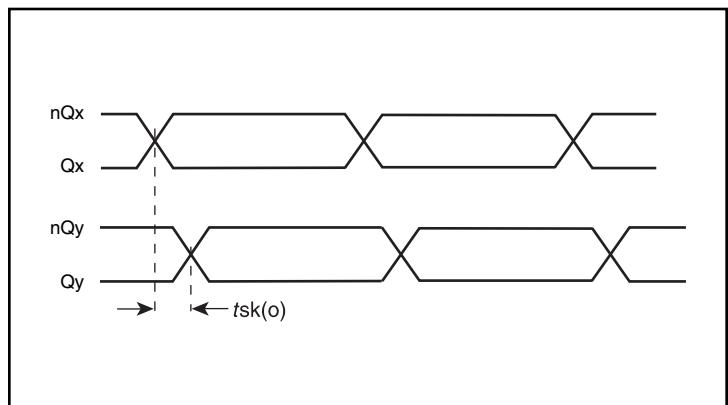
3.3V LVPECL Output Load AC Test Circuit



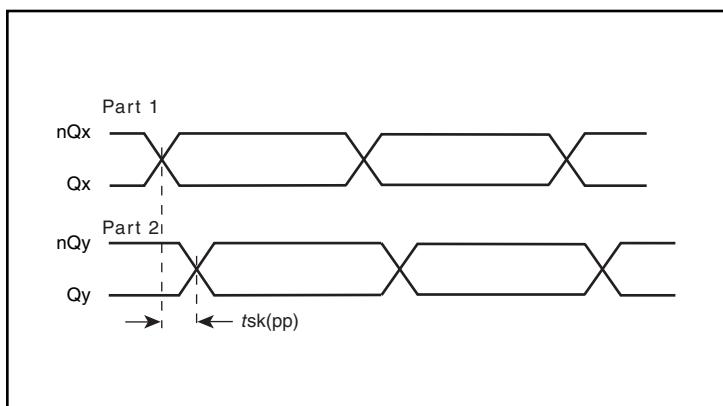
2.5V LVPECL Output Load AC Test Circuit



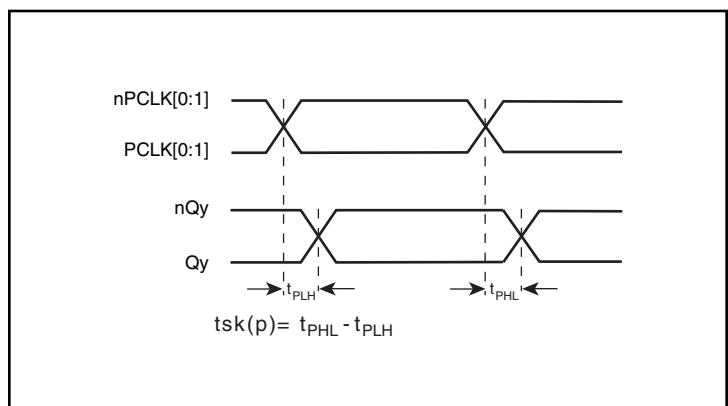
Differential Input Level



Output Skew

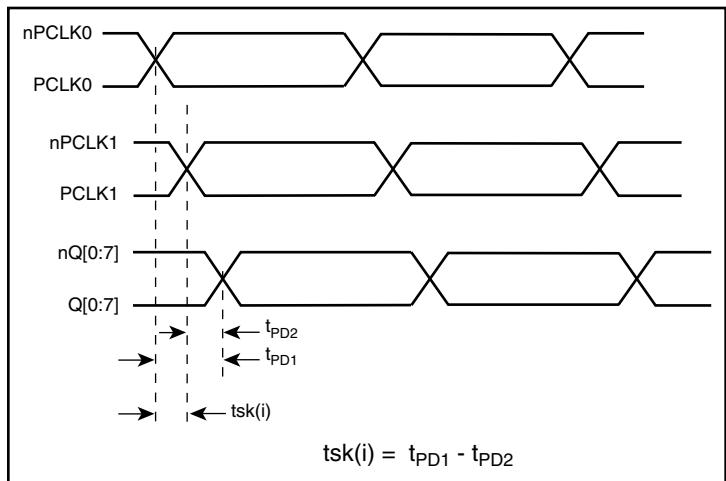


Part-to-Part Skew

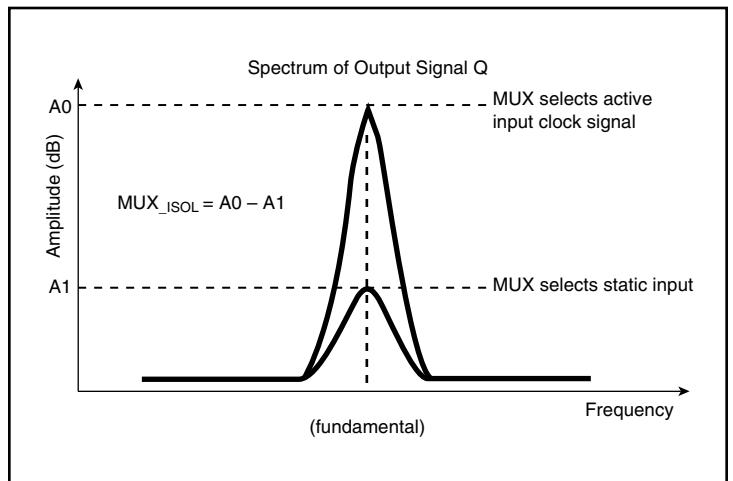


Pulse Skew

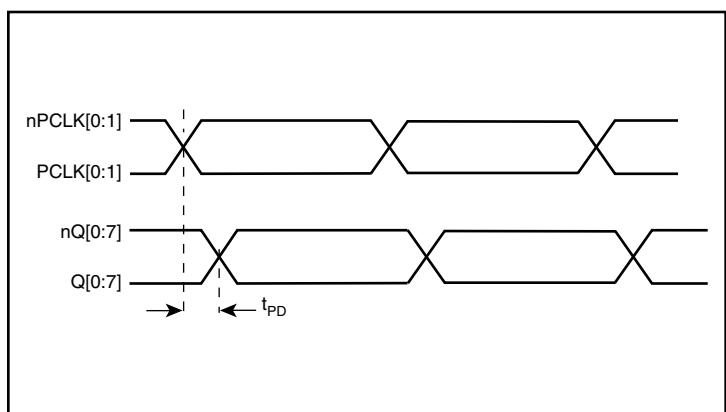
Parameter Measurement Information, continued



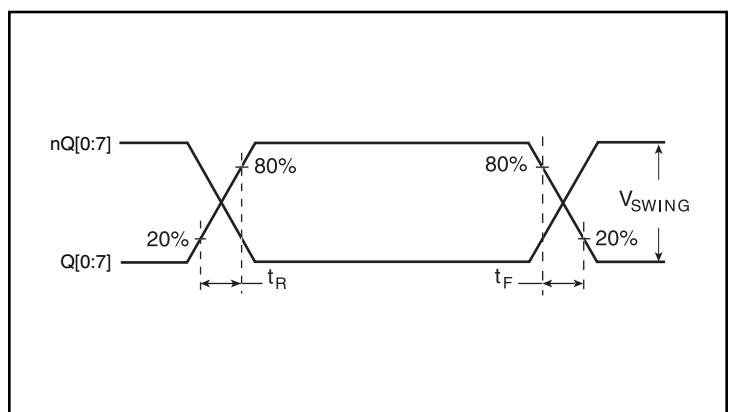
Input Skew



MUX Isolation



Propagation Delay



Output Rise/Fall Time

Applications Information

Wiring the Differential Input to Accept Single-Ended Levels

The 8SLVP1208I inputs can be interfaced to LVPECL, LVDS, CML or LVCMS drivers. *Figure 1A* illustrates how to DC couple a single LVCMS input to the 8SLVP1208. The value of the series resistance Rs is calculated as the difference between the transmission line impedance and the driver output impedance. This resistor should be placed close to the LVCMS driver. To avoid cross-coupling of single-ended LVCMS signals, apply the LVCMS signals to no more than one PCLK input.

A practical method to implement V_{th} is shown in *Figure 1B* below. The reference voltage $V_{th} = V1 = V_{CC}/2$, is generated by the bias resistors $R1$ and $R2$. The bypass capacitor ($C1$) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible.

The ratio of $R1$ and $R2$ might need to be adjusted to position the $V1$ in the center of the input voltage swing. For example, if the input clock swing is 2.5V and $V_{CC} = 3.3V$, $R1$ and $R2$ value should be adjusted to set $V1$ at 1.25V. The values below apply when both the single-ended swing and V_{CC} are at the same voltage.

When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMS signaling, it is recommended that the amplitude be reduced, particularly if both input references are LVCMS to minimize cross talk. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however V_{IL} cannot be less than -0.3V and V_{IH} cannot be more than $V_{CC} + 0.3V$.

Figure 1B shows a way to attenuate the PCLK input level by a factor of two as well as matching the transmission line between the LVCMS driver and the 8SLVP1208 at both the source and the load.

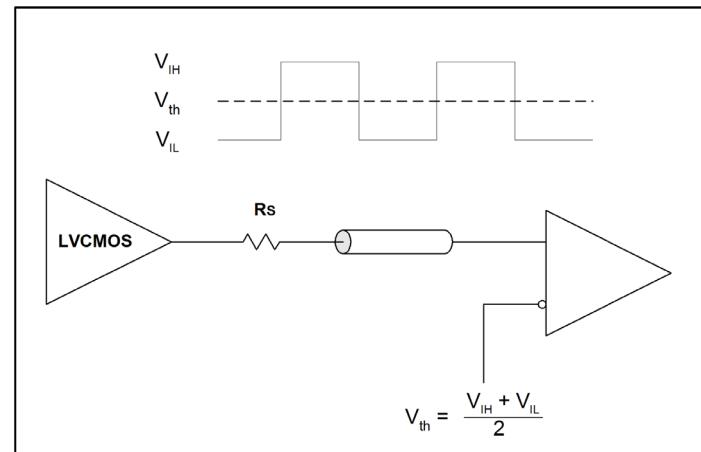


Figure 1A. DC-Coupling a Single LVCMS Input to the 8SLVP1208

This configuration requires that the sum of the output impedance of the driver (R_o) and the series resistance (R_s) equals the transmission line impedance. $R3$ and $R4$ in parallel should equal the transmission line impedance; for most 50Ω applications, $R3$ and $R4$ will be 100Ω . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMS driver.

Though some of the recommended components of *Figure 1B* might not be used, the pads should be placed in the layout so that they can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

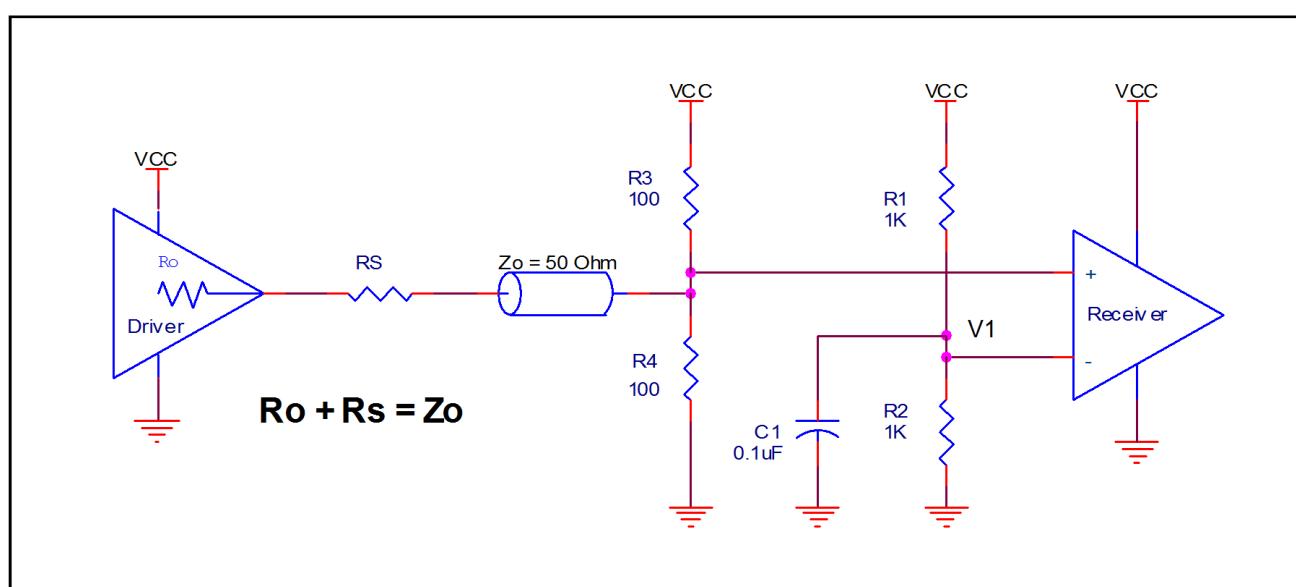


Figure 1B. Alternative DC Coupling a Single LVCMS Input to the 8SLVP1208

Recommendations for Unused Input and Output Pins

Inputs:

PCLK/nPCLK Inputs

For applications requiring only one differential input, the unused PCLK/nPCLK input can be left floating. Though not required, but for additional protection, a $1\text{k}\Omega$ resistor can be tied from PCLK to ground.

Outputs:

LVPECL Outputs

All unused LVPECL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

3.3V LVPECL Clock Input Interface

The PCLK /nPCLK accepts LVPECL, LVDS, CML and other differential signals. Both signals must meet the V_{PP} and V_{CMR} input requirements. *Figure 2A* to *Figure 2E* show interface examples for the PCLK/ nPCLK input driven by the most common driver types. The

input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.

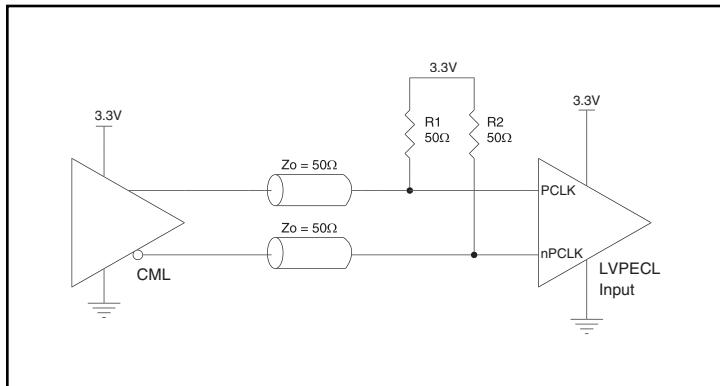


Figure 2A. PCLK/nPCLK Input Driven by a CML Driver

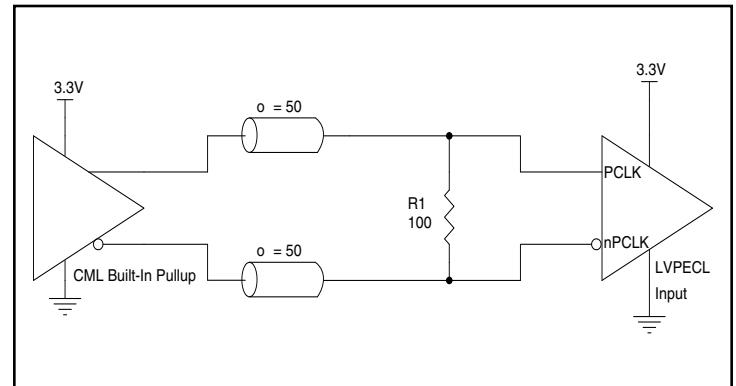


Figure 2D. PCLK/nPCLK Input Driven by a Built-In Pullup CML Driver

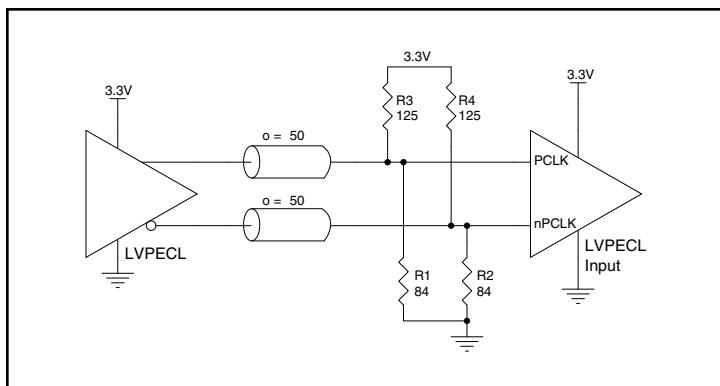


Figure 2B. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver

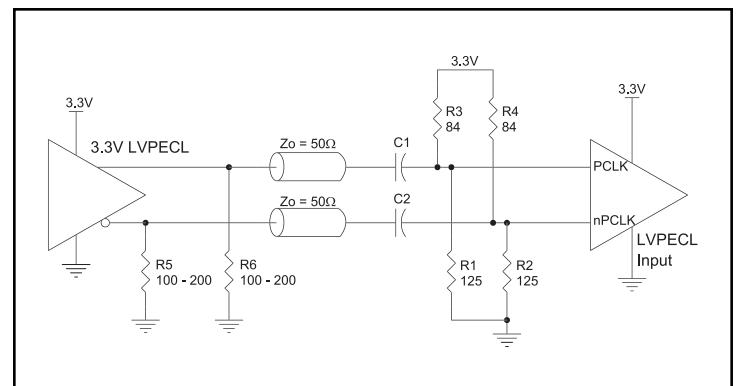


Figure 2E. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver with AC Couple

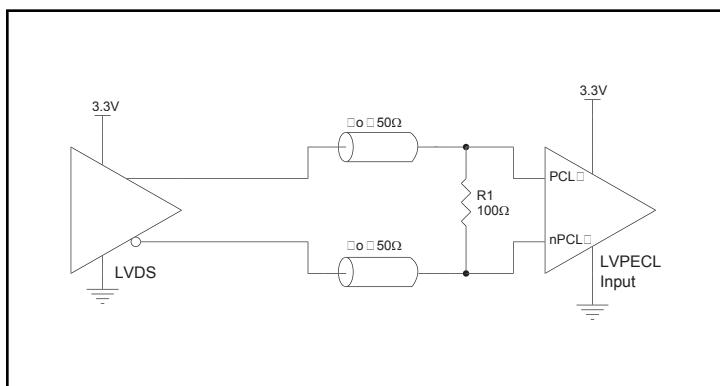


Figure 2C. PCLK/nPCLK Input Driven by a 3.3V LVDS Driver

2.5V LVPECL Clock Input Interface

The PCLK /nPCLK accepts LVPECL, LVDS, CML and other differential signals. Both signals must meet the V_{PP} and V_{CMR} input requirements. [Figure 3A](#) to [Figure 3E](#) show interface examples for the PCLK/ nPCLK input driven by the most common driver types. The

input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.

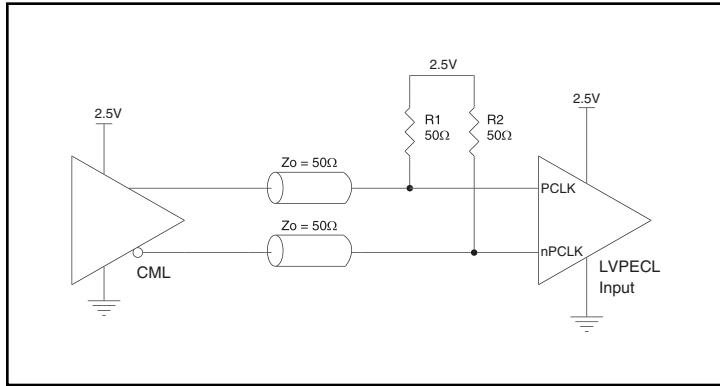


Figure 3A. PCLK/nPCLK Input Driven by a CML Driver

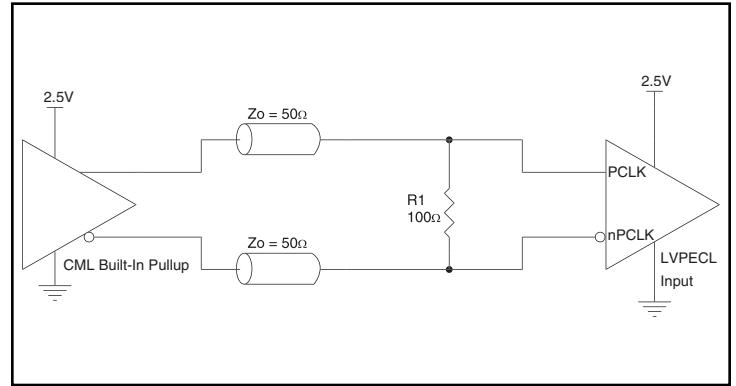


Figure 3D. PCLK/nPCLK Input Driven by a Built-In Pullup CML Driver

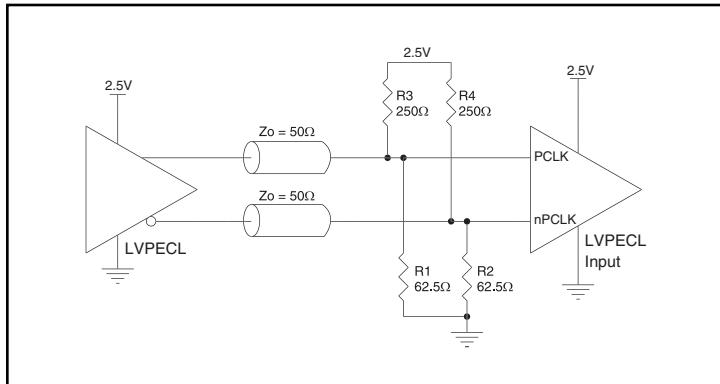


Figure 3B. PCLK/nPCLK Input Driven by a 2.5V LVPECL Driver

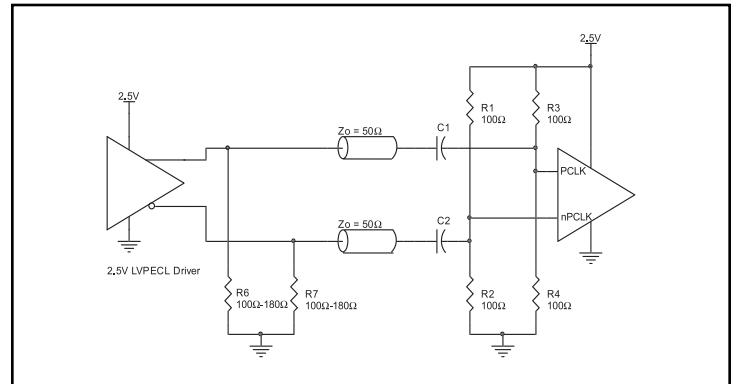


Figure 3E. PCLK/nPCLK Input Driven by a 2.5V LVPECL Driver with AC Couple

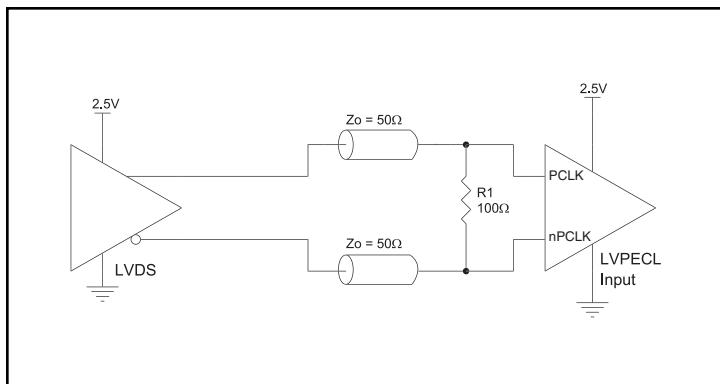


Figure 3C. PCLK/nPCLK Input Driven by a 2.5V LVDS Driver

VFQFN EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 4*. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts. While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific

and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/Electrically Enhance Leadframe Base Package, Amkor Technology.

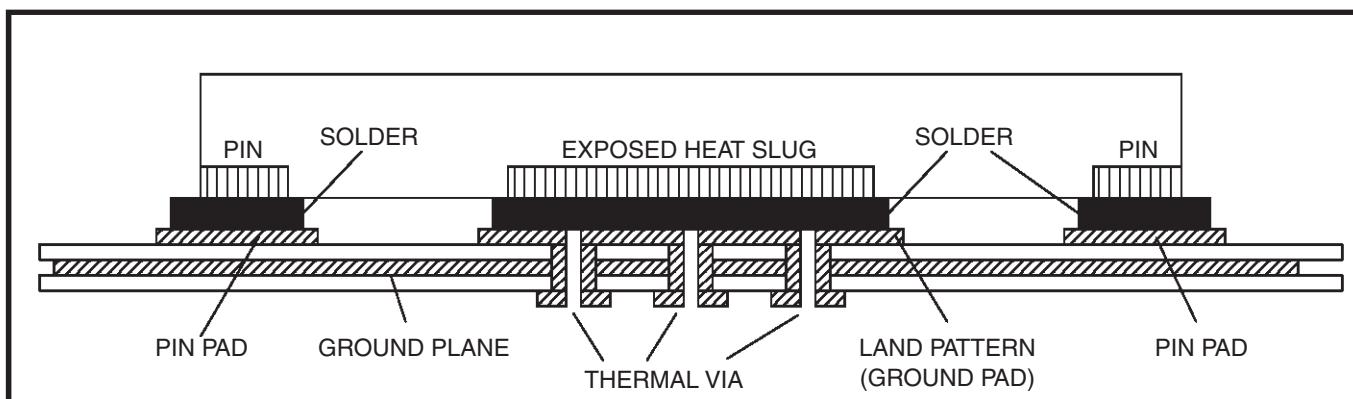


Figure 4. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale)

Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are a low impedance follower output that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive 50Ω

transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion.

Figure 5A and *Figure 5B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

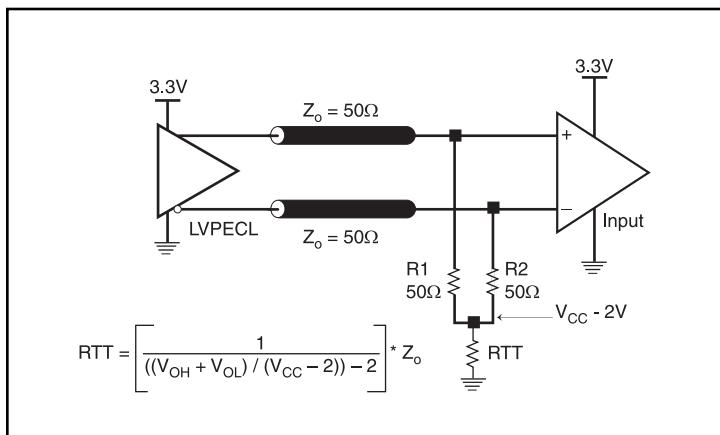


Figure 5A. 3.3V LVPECL Output Termination

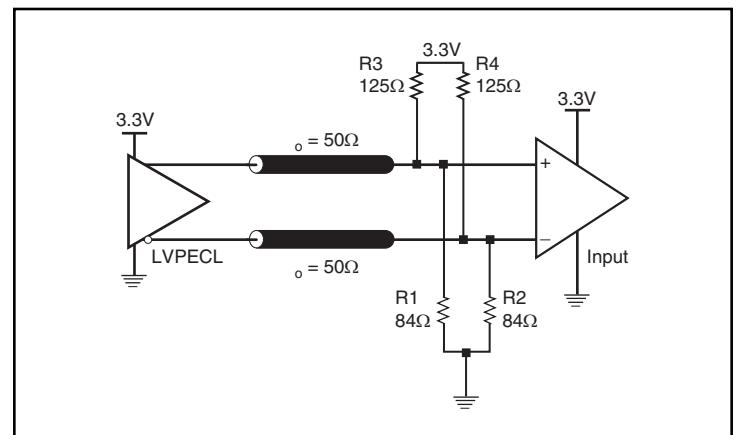


Figure 5B. 3.3V LVPECL Output Termination

Termination for 2.5V LVPECL Outputs

Figure 6A and *Figure 6B* show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating 50Ω to $V_{CC} - 2V$. For $V_{CC} = 2.5V$, the $V_{CC} - 2V$ is very close to ground

level. The $R3$ in *Figure 6B* can be eliminated and the termination is shown in *Figure 6C*.

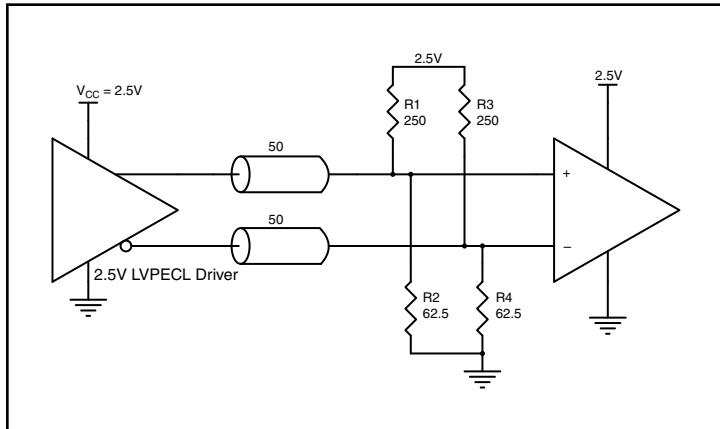


Figure 6A. 2.5V LVPECL Driver Termination Example

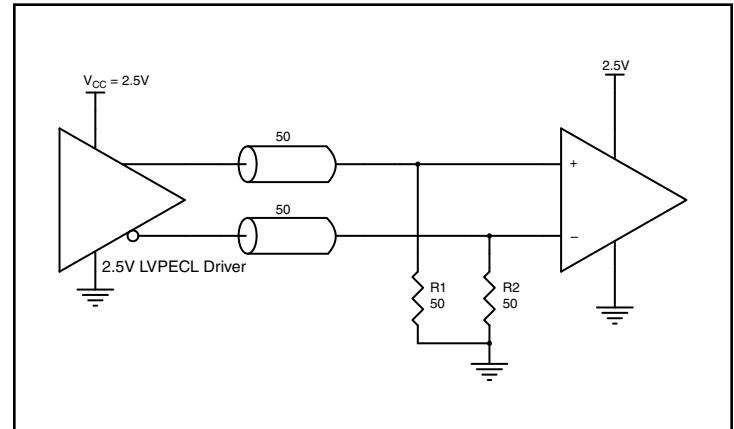


Figure 6C. 2.5V LVPECL Driver Termination Example

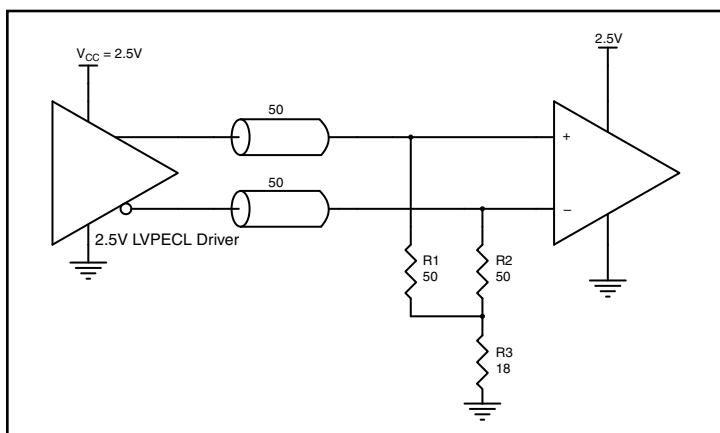


Figure 6B. 2.5V LVPECL Driver Termination Example

Power Considerations

This section provides information on power dissipation and junction temperature for the 8SLVP1208. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the 8SLVP1208 is the sum of the core power plus the power dissipated at the output(s). The following is the power dissipation for $V_{CC} = 3.465V$, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated at the outputs.

- Power (core)_{MAX} = $V_{CC_MAX} * I_{EE_MAX} = 3.465V * 141mA = 488.57mW$
- Power (outputs)_{MAX} = **29.4mW/Loaded Output pair**
If all outputs are loaded, the total power is $8 * 29.4mW = 235.2mW$

Total Power_{MAX} (3.465V, with all outputs switching) = $488.57mW + 235.2mW = 723.77mW$

2. Junction Temperature.

Junction temperature, T_j , is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, T_j , to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for T_j is as follows: $T_j = \theta_{JA} * P_{d_total} + T_A$

T_j = Junction Temperature

θ_{JA} = Junction-to-Ambient Thermal Resistance

P_{d_total} = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 46.2°C/W per [Table 6](#) below.

Therefore, T_j for an ambient temperature of 85°C with all outputs switching is:

$85^\circ C + 0.724W * 46.2^\circ C/W = 118.4^\circ C$. This is below the limit of 125°C.

This calculation is only an example. T_j will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 6. Thermal Resistance θ_{JA} for 28-Lead VFQFN, Forced Convection

θ_{JA} by Velocity			
Meters per Second	0	1	2
Multi-Layer PCB, JEDEC Standard Test Boards	46.2°C/W	39.4°C/W	37.1°C/W

3. Calculations and Equations.

The purpose of this section is to calculate the power dissipation for the LVPECL output pair.

LVPECL output driver circuit and termination are shown in *Table 7*.

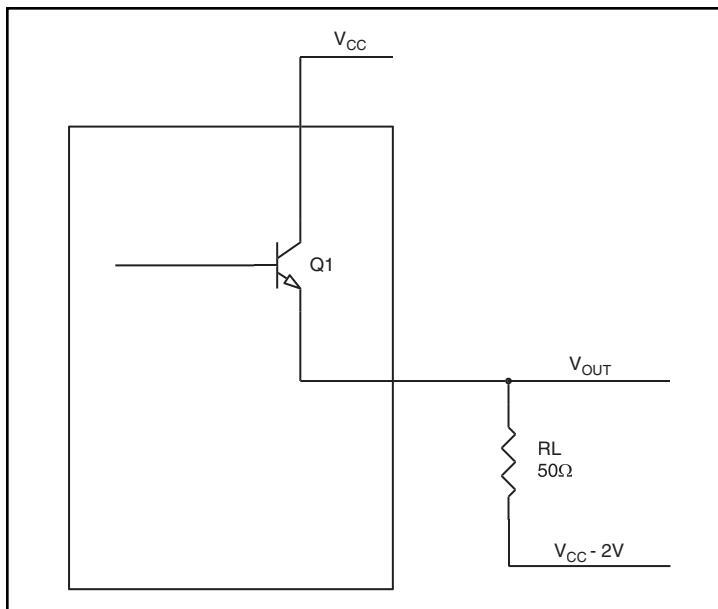


Figure 7. LVPECL Driver Circuit and Termination

To calculate worst case power dissipation at the output(s), use the following equations which assume a 50Ω load, and a termination voltage of $V_{CC} - 2V$.

- For logic high, $V_{OUT} = V_{OH_MAX} = V_{CC_MAX} - 0.8V$
 $(V_{CC_MAX} - V_{OH_MAX}) = 0.8V$
- For logic low, $V_{OUT} = V_{OL_MAX} = V_{CC_MAX} - 1.7V$
 $(V_{CC_MAX} - V_{OL_MAX}) = 1.7V$

Pd_H is the power dissipation when the output drives high.

Pd_L is the power dissipation when the output drives low.

$$Pd_H = [(V_{OH_MAX} - (V_{CC_MAX} - 2V))/R_L] * (V_{CC_MAX} - V_{OH_MAX}) = [(2V - (V_{CC_MAX} - V_{OH_MAX}))/R_L] * (V_{CC_MAX} - V_{OH_MAX}) = [(2V - 0.8V)/50\Omega] * 0.8V = 19.2mW$$

$$Pd_L = [(V_{OL_MAX} - (V_{CC_MAX} - 2V))/R_L] * (V_{CC_MAX} - V_{OL_MAX}) = [(2V - (V_{CC_MAX} - V_{OL_MAX}))/R_L] * (V_{CC_MAX} - V_{OL_MAX}) = [(2V - 1.7V)/50\Omega] * 1.7V = 10.2mW$$

$$\text{Total Power Dissipation per output pair} = Pd_H + Pd_L = 29.4mW$$

Reliability Information

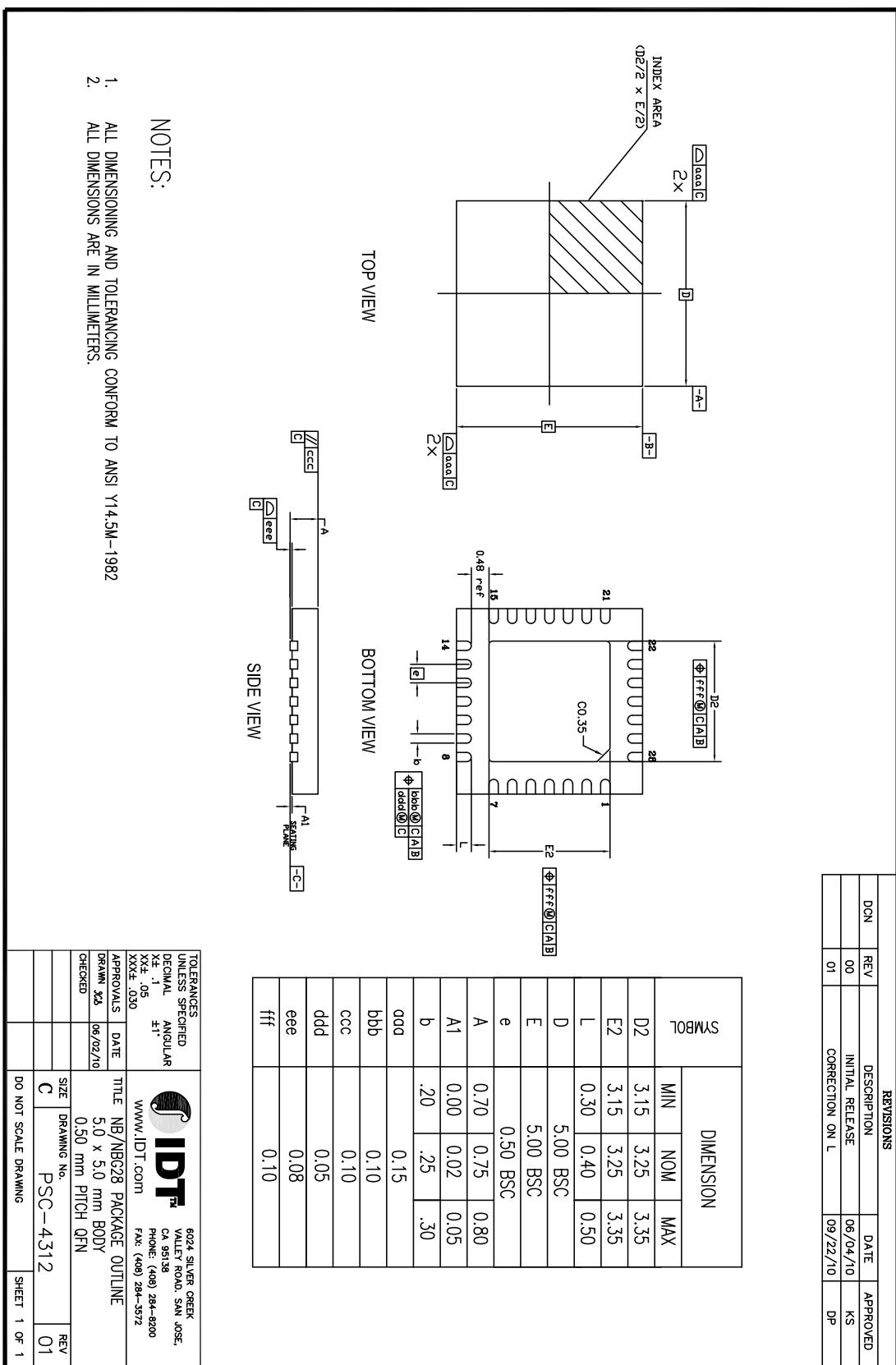
Table 7. θ_{JA} vs. Air Flow Table for a 28-Lead VFQFN

θ_{JA} at 0 Air Flow			
Meters per Second	0	1	2
Multi-Layer PCB, JEDEC Standard Test Boards	46.2°C/W	39.4°C/W	37.1°C/W

Transistor Count

The transistor count for the 8SLVP1208 is: 304

28-Lead VFQFN Package Outline and Package Dimensions



TOLERANCES UNLESS SPECIFIED DECIMAL XX-.1 XX+.05 XX-.05 XX+.05 XX-.05 XX+.05		6024 SILVER CREEK VALLEY ROAD, SAN JOSE, CA 95138 PHONE: (408) 284-8200 FAX: (408) 284-3572 www.IDT.com	
TITLE		NB/NBG38 PACKAGE OUTLINE	
APPROVALS		5.0 mm BODY 0.50 mm PITCH QFN	
DRAWN	06/02/10	SIZE	DRAWING No.
CHECKED		C	PSC-4312
			REV 01
DO NOT SCALE DRAWING		SHEET 1 OF 1	

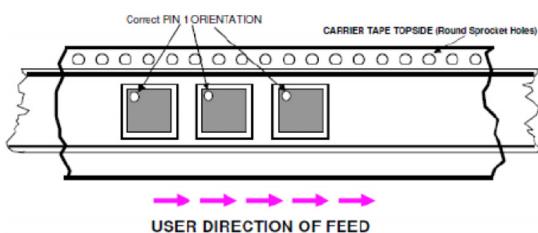
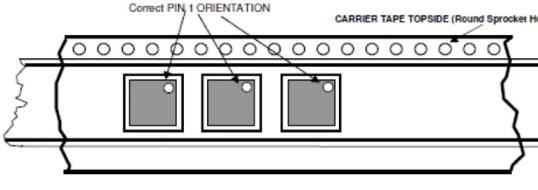
Ordering Information

Table 8. Ordering Information¹

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
8SLVP1208ANBGI	LVP1208ANBGI	"Lead-Free" 28-Lead VFQFN	Tray	-40°C to 85°C
8SLVP1208ANBGI8	LVP1208ANBGI	"Lead-Free" 28-Lead VFQFN	Tape & Reel, Pin 1 Orientation: EIA-481-C	-40°C to 85°C
8SLVP1208ANBGI/W	LVP1208ANBGI	"Lead-Free" 28-Lead VFQFN	Tape & Reel, Pin 1 Orientation: EIA-481-D	-40°C to 85°C

NOTE 1: Parts that are ordered with an "G" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

Table 9. Pin 1 Orientation in Tape and Reel Packaging

Part Number Suffix	Pin 1 Orientation	Illustration
8	Quadrant 1 (EIA-481-C)	
/W	Quadrant 2 (EIA-481-D)	

Revision History Sheet

Rev	Table	Page	Description of Change	Date
A		7	Additive Phase Noise Plot label, corrected units from 35.9ps to 35.9fs. Corrected page headers from 1:8, LVPECL Output Fanout Buffer to 2:8, LVPECL.	4/23/2012
A	T8, T9	20	Ordering Information Table - added additional row. Added Orientation Packaging Table.	8/02/2012
A	T4A	1 5 10	Added Features Bullet: Differential PCLKA, nPCLKA and PCLKB, nPCLKB pairs can also accept single-ended LVCMOS levels. Added NOTE 8 to V_{PP} , V_{CMR} . Updated the "Wiring the Differential Input to Accept Single-Ended Levels" note.	1/30/2013
A	T5A	5	Changed NOTE 6 to read: V_{IL} should not be less than -0.3V. V_{IH} should not be higher than V_{CC} .	1/27/2014
A		14	Corrected page layout formatting.	3/25/2014
A	T5A	5 23	Fixed typo: V_{DIFF_OUT} , Test Conditions - $V_{CC} = 3.3V$, $f_{REF} \leq 2GHz$. Updated contact information. Updated format.	8/28/2014



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